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Cok et al.

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(54) **METHOD AND APPARTUS FOR UNIFORMITY AND BRIGHTNESS CORRECTION IN A DISPLAY**

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(73) Assignee: **Global OLED Technology LLC**, Herndon, VA (US)

(*) Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(b) by 840 days.

This patent is subject to a terminal disclaimer.

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(51) **Int. Cl.**

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G09G 3/32	(2006.01)
G09G 5/00	(2006.01)
G06F 3/038	(2006.01)

(52) **U.S. Cl.** **345/77**; 345/82; 345/204

(58) **Field of Classification Search** 345/30–84

See application file for complete search history.

(56) **References Cited**

U.S. PATENT DOCUMENTS

6,081,073	A	6/2000	Salam	
6,414,661	B1	7/2002	Shen et al.	345/82
6,473,065	B1 *	10/2002	Fan	345/82
6,989,636	B2	1/2006	Cok et al.	315/169.3
7,092,081	B2	8/2006	Wang et al.	356/218
2002/0105279	A1	8/2002	Kimura	315/169.3
2004/0257352	A1	12/2004	Naughler, Jr. et al.	345/204

(Continued)

OTHER PUBLICATIONS

U.S. Appl. No. 10/858,260, filed Jun. 1, 2004, Ronald S. Cok et al; "Uniformity And Brightness Meaasurement in OLED Displays". cited by other.

(Continued)

Primary Examiner — Alexander S Beck
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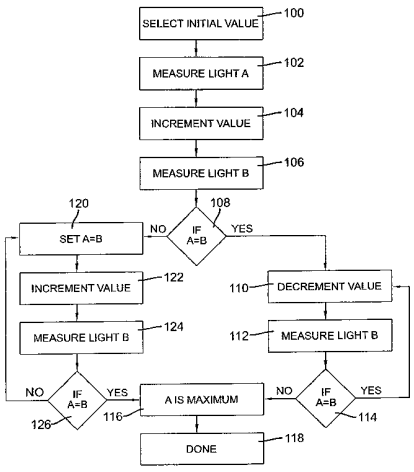
(57) **ABSTRACT**

A method for the correction of average brightness or brightness uniformity variations in electroluminescent (EL) displays comprising: a) providing an EL display having one or more light-emitting elements responsive to a multi-valued input signal for causing the light-emitting elements to emit light at a plurality of brightness levels; b) measuring the brightness of each light-emitting element at two or more, but fewer than all possible, different input signal values; c) employing the measured brightness values to estimate a maximum input signal value at which the light-emitting element will not emit more than a predefined minimum brightness and the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal; and d) using the estimated maximum input signal value at which the light-emitting element will not emit light more than the predefined minimum brightness and the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal to modify the input signal to a corrected input signal to correct the light output of the light-emitting elements.

20 Claims, 8 Drawing Sheets



U.S. PATENT DOCUMENTS

2005/0088380	A1*	4/2005	Bulovic et al.	345/77
2005/0280615	A1	12/2005	Cok et al.	345/77
2006/0061248	A1	3/2006	Cok et al.	313/110
2006/0063281	A1	3/2006	Cok et al.	438/14
2006/0077136	A1	4/2006	Cok	345/76
2006/0114451	A1	6/2006	Wang et al.	356/218
2006/0132400	A1	6/2006	Cok et al.	345/81
2006/0221326	A1	10/2006	Cok et al.	

OTHER PUBLICATIONS

U.S. Appl. No. 10/8869,009; filed Jun. 16, 2004, Ronald S. Cok et al; "Method and Apparatus For Uniformity And Brightness Corrrection in An OLED Displays". cited by other.

U.S. Appl. No. 10/894,729; filed Jul. 20, 2004, Ronald S. Cok et al; Method And Apparatus for Uniformity And Brightness Correction In An OLED cited by other.

* cited by examiner

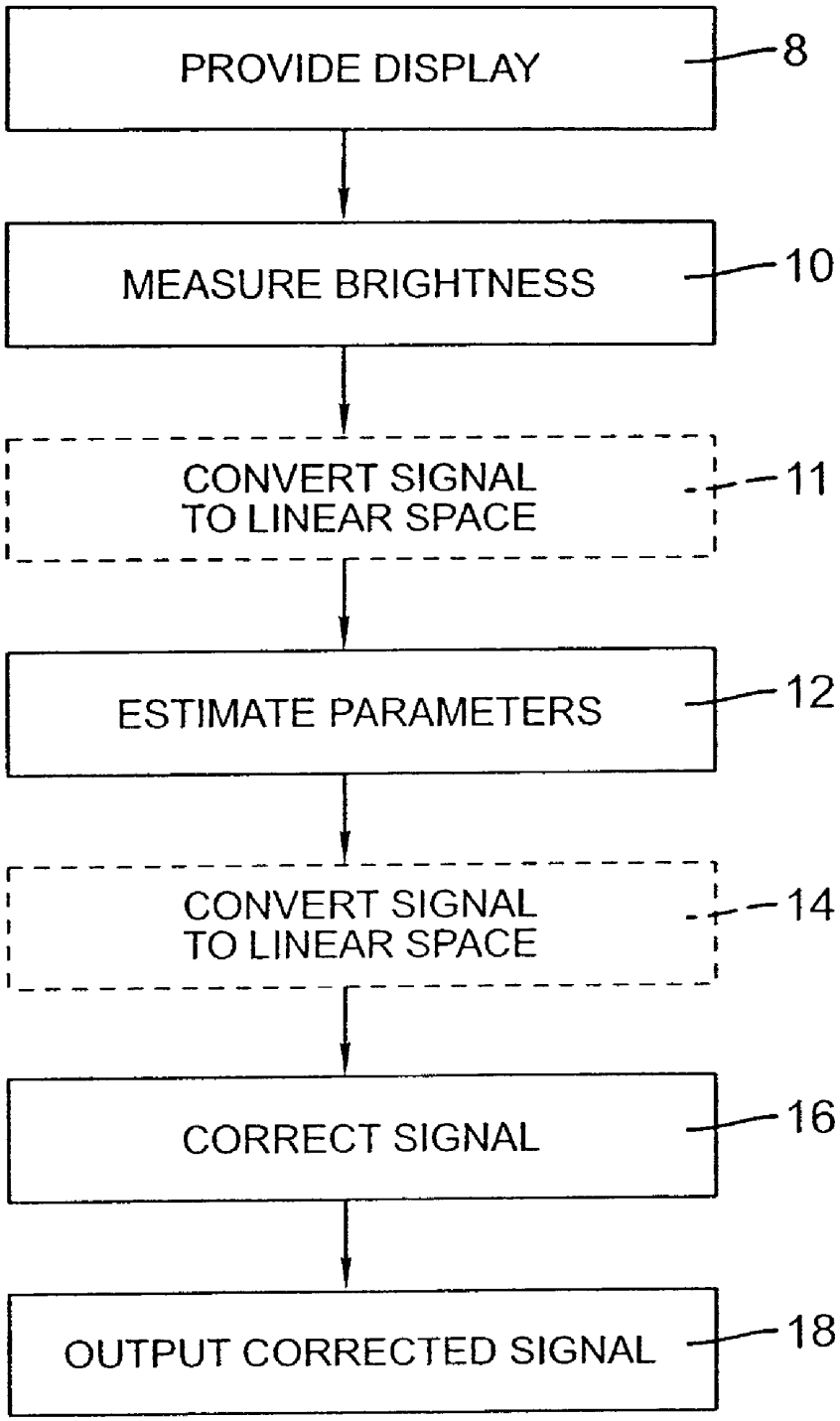

PROVIDE DISPLAY
8
MEASURE BRIGHTNESS
10
CONVERT SIGNAL TO LINEAR SPACE
11
ESTIMATE PARAMETERS
12
CONVERT SIGNAL TO LINEAR SPACE
14
CORRECT SIGNAL
16
OUTPUT CORRECTED SIGNAL
18

FIG. 1

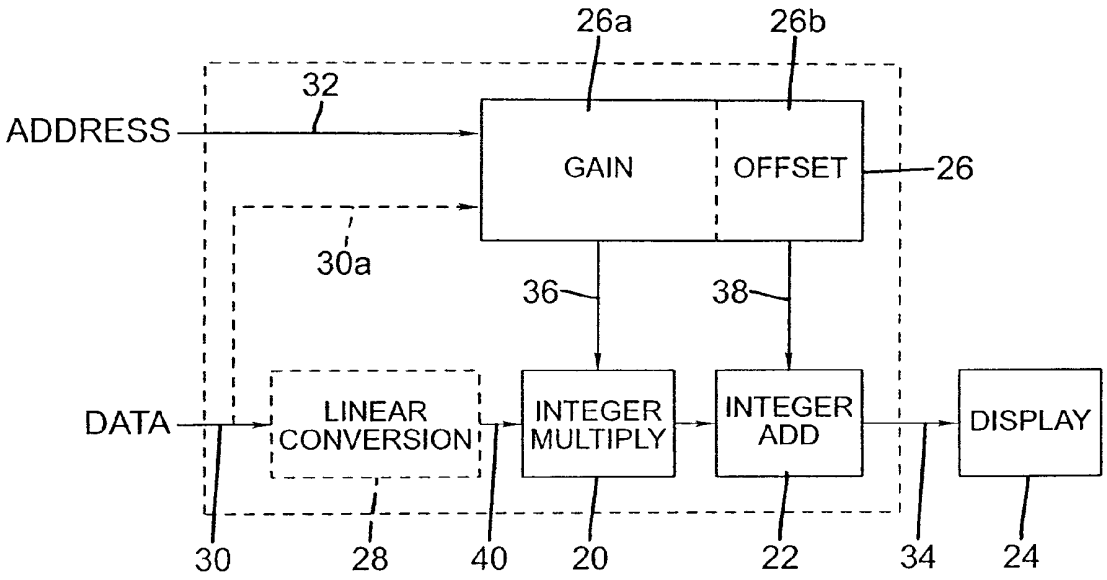


FIG. 2

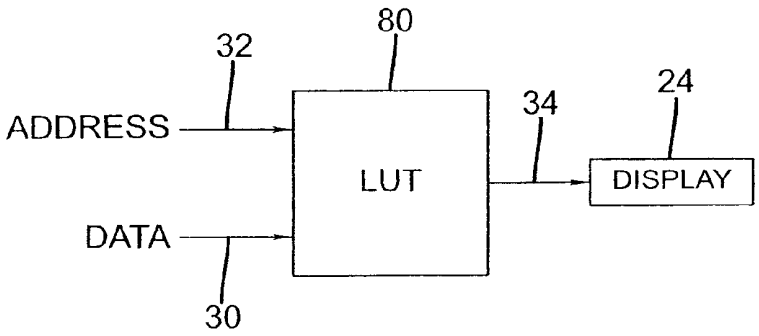


FIG. 3
PRIOR ART

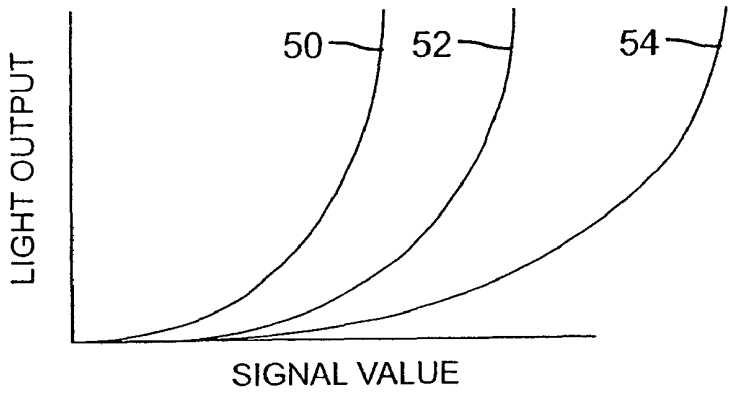


FIG. 4a

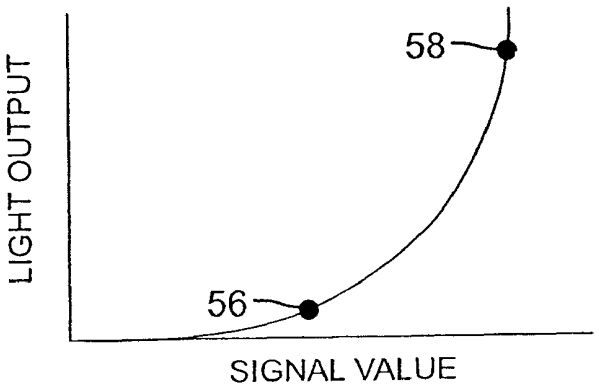


FIG. 4b

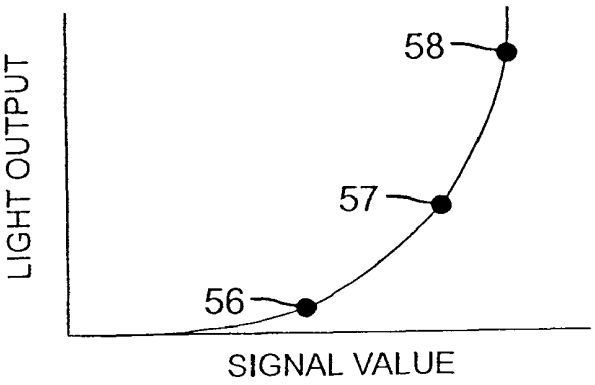


FIG. 4c

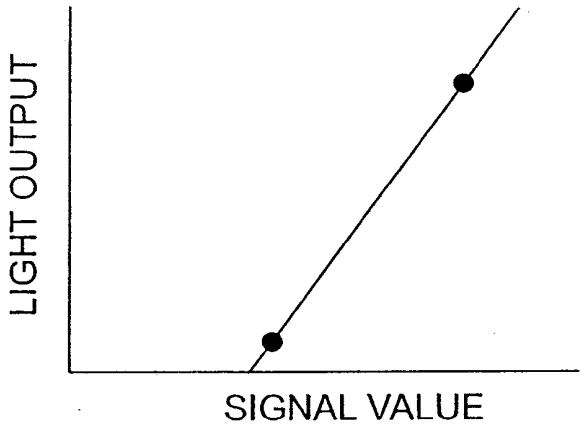


FIG. 4d

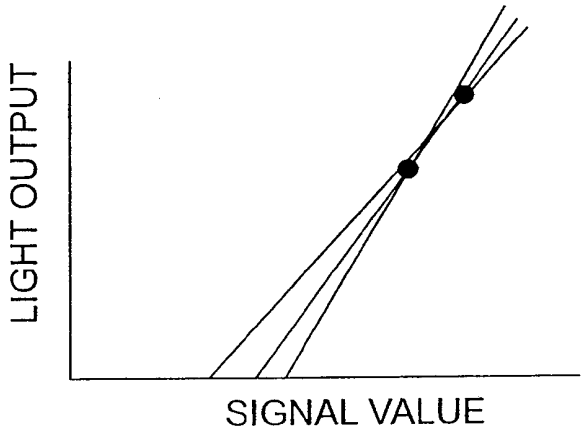


FIG. 4e

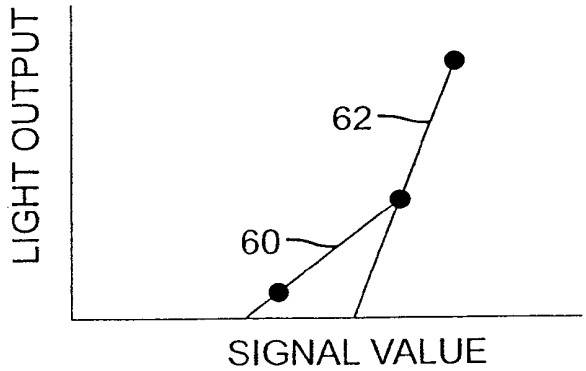


FIG. 4f

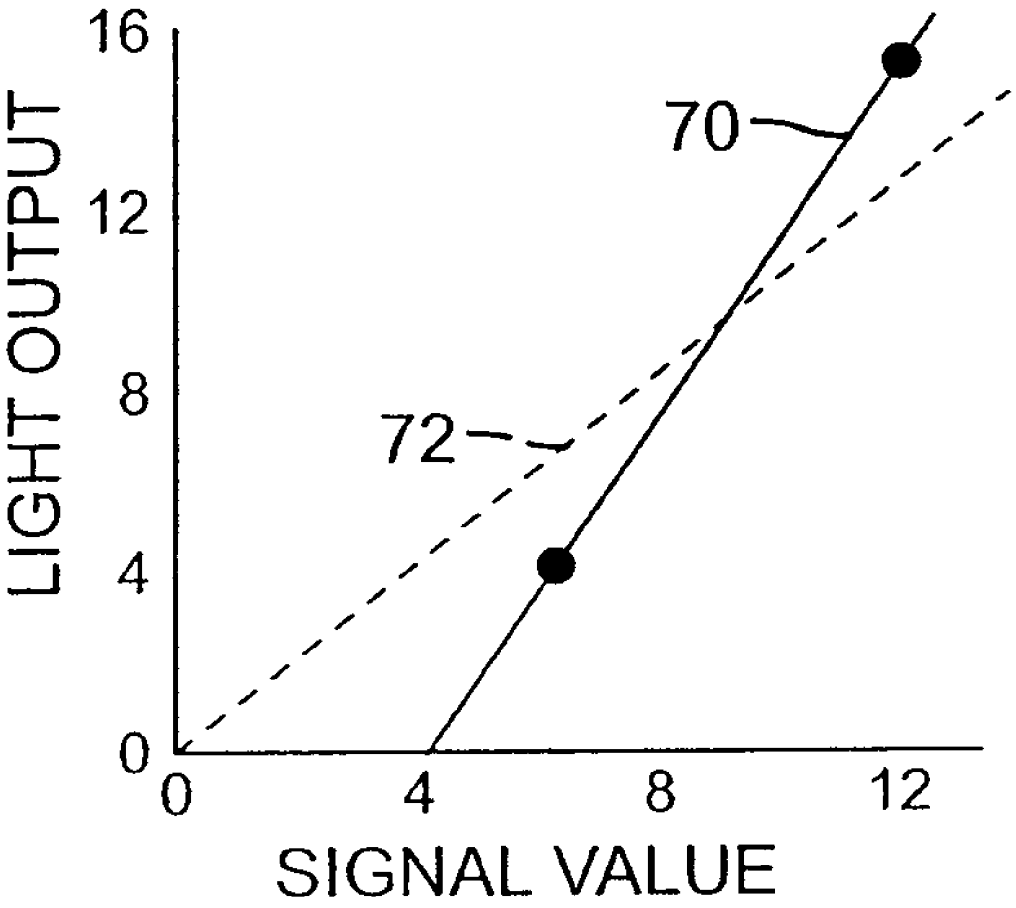


FIG. 5

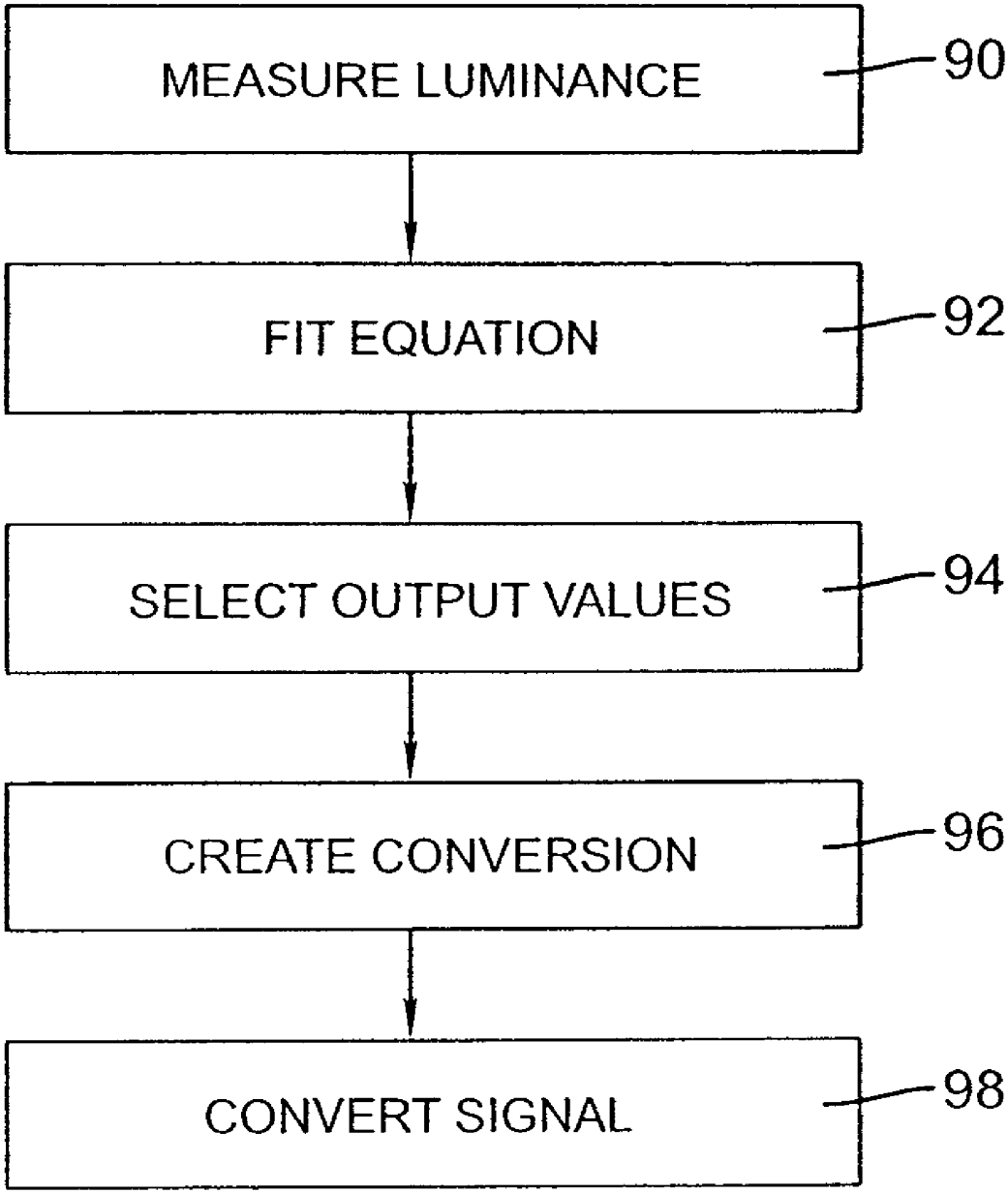

MEASURE LUMINANCE
90
FIT EQUATION
92
SELECT OUTPUT VALUES
94
CREATE CONVERSION
96
CONVERT SIGNAL
98

FIG. 6

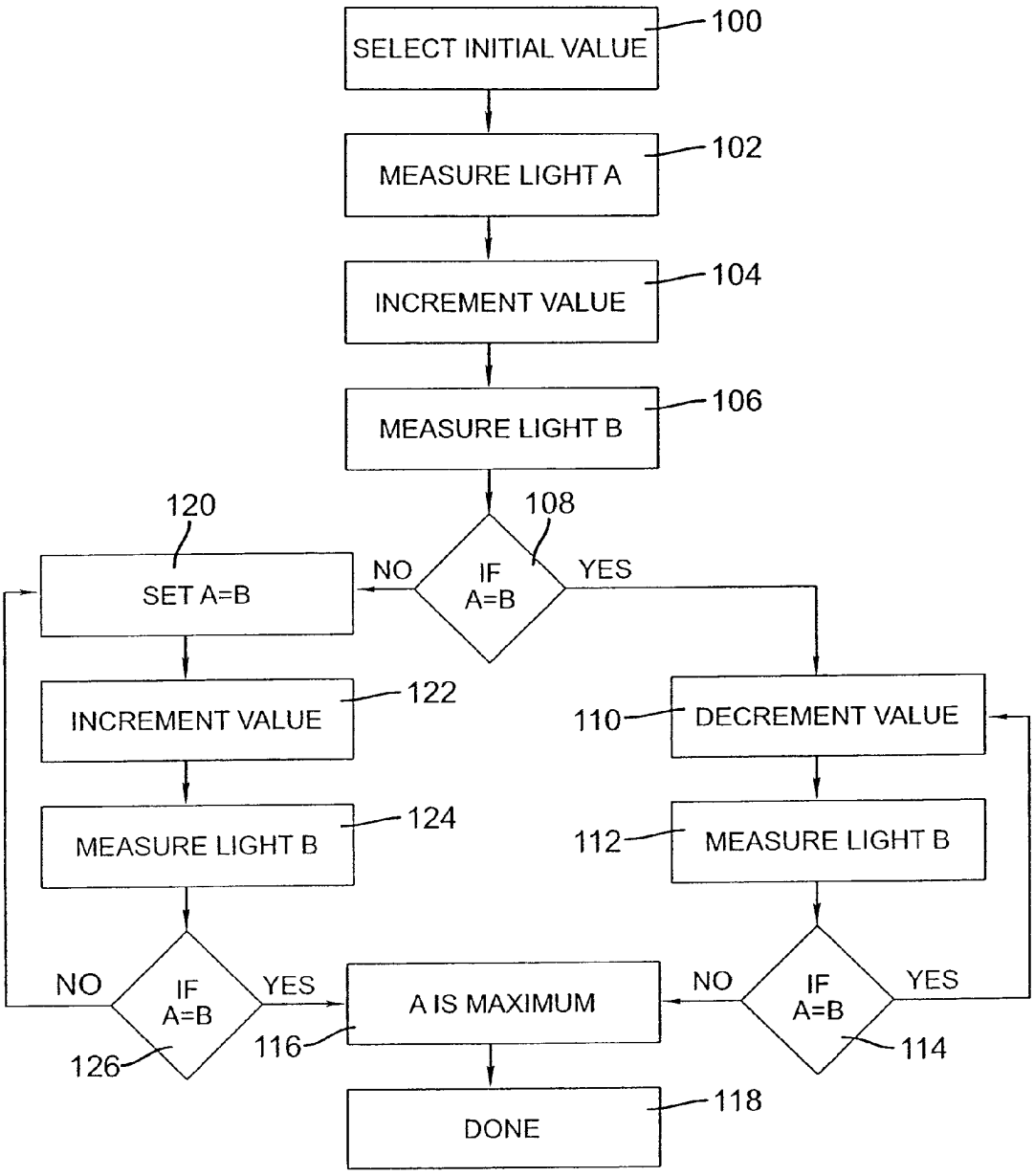

SELECT INITIAL VALUE
100
MEASURE LIGHT A
102
INCREMENT VALUE
104
MEASURE LIGHT B
106
120
108
SET A=B
NO
IF A=B
YES
INCREMENT VALUE
122
110
DECREMENT VALUE
MEASURE LIGHT B
124
112
MEASURE LIGHT B
NO
IF A=B
YES
A IS MAXIMUM
NO
IF A=B
YES
126
116
114
DONE
118

FIG. 7

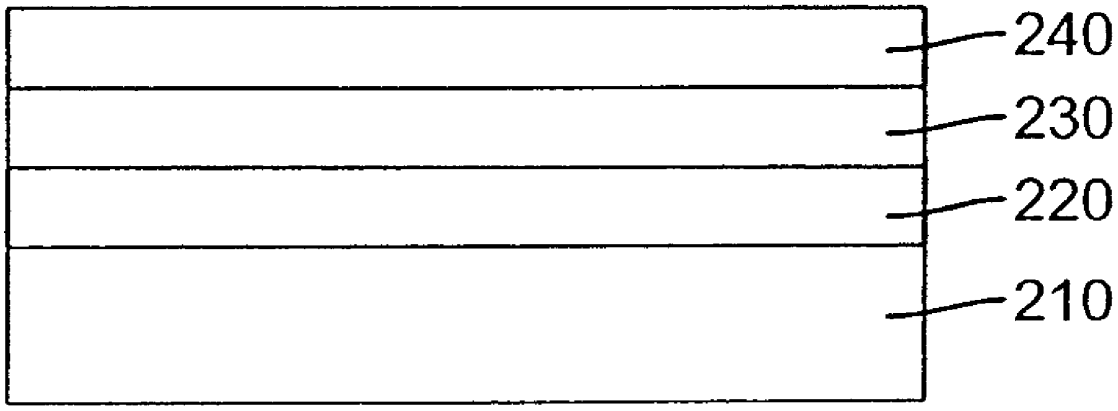


FIG. 8
PRIOR ART

METHOD AND APPARTUS FOR UNIFORMITY AND BRIGHTNESS CORRECTION IN A DISPLAY

CROSS REFERENCE TO RELATED APPLICATIONS

This is a continuation-in-part of application Ser. No. 11/093,115, filed Mar. 29, 2005 entitled now U.S. Pat. No. 7,301,618, "Method And Apparatus For Uniformity And Brightness Correction In An OLED Display", by Ronald S. Cok, et al.

FIELD OF THE INVENTION

The present invention relates to electroluminescent (EL) displays having a plurality of light-emitting elements and, more particularly, to correcting brightness of the light-emitting elements in the display.

BACKGROUND OF THE INVENTION

Flat-panel display devices, for example plasma, liquid crystal and electroluminescent (EL) displays have been known for some years and are widely used in electronic devices to display information and images. EL display devices rely upon thin-film layers of materials coated upon a substrate, and include organic, inorganic and hybrid inorganic-organic light-emitting diodes (LEDs). The thin-film layers of materials can include, for example, organic materials, quantum dots, fused inorganic nano-particles, electrodes, conductors, and silicon or metal oxide electronic components as are known and taught in the LED art. Such devices employ both active-matrix and passive-matrix control schemes and can employ a plurality of light-emitting elements. The light-emitting elements are typically arranged in two-dimensional arrays with a row and a column address for each light-emitting element and having a data value associated with each light-emitting element to emit light at a brightness corresponding to the associated data value.

However, such displays suffer from a variety of defects that limit the quality of the displays. In particular, EL displays suffer from non-uniformities in the light-emitting elements. These non-uniformities can be attributed to both the light emitting materials in the display and, for active-matrix displays, to variability in the thin-film transistors used to drive the light emitting elements.

It is known in the prior art to measure the performance of each pixel in a display and then to correct for the performance of the pixel to provide a more uniform output across the display. U.S. Pat. No. 6,081,073 entitled "Matrix Display with Matched Solid-State Pixels" by Salam granted Jun. 27, 2000 describes a display matrix with a process and control means for reducing brightness variations in the pixels. This patent describes the use of a linear scaling method for each pixel based on a ratio between the brightness of the weakest pixel in the display and the brightness of each pixel. However, this approach will lead to an overall reduction in the dynamic range and brightness of the display and a reduction and variation in the bit depth at which the pixels can be operated.

U.S. Pat. No. 6,473,065 B1 entitled "Methods of improving display uniformity of organic light emitting displays by calibrating individual pixel" by Fan issued Oct. 29, 2002 describes methods of improving the display uniformity of an OLED. In order to improve the display uniformity of an OLED, the display characteristics of all organic-light-emitting-elements are measured, and calibration parameters for each organic-light-emitting-element are obtained from the measured display characteristics of the corresponding organic-light-emitting-element. The calibration parameters of each organic-light-emitting-element are stored in a calibration memory. The technique uses a combination of look-up tables and calculation circuitry to implement uniformity correction. However, the described approaches require either a lookup table providing a complete characterization for each pixel, or extensive computational circuitry within a device controller. This is likely to be expensive and impractical in most applications.

There is a need, therefore, for an improved method of providing uniformity in an EL display that overcomes these objections.

SUMMARY OF THE INVENTION

In accordance with one embodiment, the invention is directed towards a method for the correction of average brightness or brightness uniformity variations in electroluminescent (EL) displays comprising:

a) providing an EL display having one or more light-emitting elements responsive to a multi-valued input signal for causing the light-emitting elements to emit light at a plurality of brightness levels;

b) measuring the brightness of each light-emitting element at two or more, but fewer than all possible, different input signal values;

c) employing the measured brightness values to estimate a maximum input signal value at which the light-emitting element will not emit more than a predefined minimum brightness and the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal; and

d) using the estimated maximum input signal value at which the light-emitting element will not emit light more than the predefined minimum brightness and the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal to modify the input signal to a corrected input signal to correct the light output of the light-emitting elements.

ADVANTAGES

In accordance with various embodiments, the present invention may provide the advantage of improved uniformity in a display that reduces the complexity of calculations, minimizes the amount of data that must be stored, improves the yields of the manufacturing process, and reduces the electronic circuitry needed to implement the uniformity calculations and transformations.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. **1** is a flow diagram illustrating the method of the present invention;

FIG. **2** is a schematic diagram illustrating an embodiment of the present invention.

FIG. **3** is a schematic diagram illustrating an embodiment of the prior art.

FIGS. **4***a*-**4***f* are graphs illustrating relationship between signal values and light output.

FIG. **5** is a graph illustrating relationship between signal values and light output.

FIG. **6** is a flow diagram according to an embodiment of the present invention;

FIG. **7** is a flow diagram according to an embodiment of the present invention; and

FIG. **8** is a prior-art partial cross-section of an exemplary EL light-emitting element useful for the present invention.

DETAILED DESCRIPTION OF THE INVENTION

Referring to FIG. **1**, the present invention is directed to a method and apparatus for the correction of brightness and uniformity variations in electroluminescent (EL) displays, comprising providing **8** an EL display having one or more light-emitting elements responsive to a multi-valued input signal for causing the light-emitting elements to emit light at a plurality of brightness levels; measuring **10** the brightness of each light-emitting element at two or more, but fewer than all possible, different input signal values; employing the measured brightness values to estimate **12** a maximum input signal value at which the light-emitting element will not emit more than a predefined minimum brightness (the offset) and the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal (the gain); and using the estimated maximum input signal value at which the light-emitting element will not emit light more than the predefined minimum brightness and the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal to modify the input signal to a corrected input signal to correct **16** the light output of the light-emitting elements. Finally, a corrected input signal for each pixel may be output **18** to a display for viewing by an observer. In a preferred embodiment, the input signal may be converted **14** into a linear space before correcting **16** if the input signal is not in an appropriate linear space for correction and output to a display. In a further preferred embodiment, the measured brightness values may also be converted **11** into the same linear space. Such conversions may be common to all light emitting elements, or to all light emitting elements of a particular color.

Referring to FIG. **3**, a prior-art system is described. In FIG. **3**, a correction lookup table **80** provides an output signal value **34** for each input signal data value **30** for each location (address signal **32**) of a light-emitting element (pixel) in a display **24**. The correction values in the correction table **80** may be obtained by a variety of means known in the prior art, for example using a camera to obtain the output brightness of each pixel for each data signal input. The correction table **80** then provides a corrected output value **34** to cause the pixel to output at the desired brightness for each input value. If a display **24** is completely uniform and at the desired brightness for each input signal **30**, then the correction table output matches the input for each pixel. If a display **24** is not completely uniform or at the desired brightness for each input signal, then the correction table **80** supplies the corrected output signal **34** that will drive the desired display output.

In the most complete case, this approach requires a lookup table value for each pixel at each input signal value. For example, if a display incorporates a 1,000 by 1,000 array of pixels at a signal bit depth of 8 bits, a 256 MByte memory is required. If each pixel in the display is a color pixel, then additional memory must be employed for each color, resulting in a requirement of 768 MBytes. Even for relatively small displays, e.g. 100 by 100 pixels, this requirement is a significant 7.68 MBytes. Hence, such a design may be impractical for cost or packaging reasons. While alternative solutions requiring less memory (e.g., use of linear interpolations between fewer data points) may be employed, such approaches may be less accurate, particularly for device responses that are non-linear and may require extensive computational hardware.

Referring to FIG. **2**, one embodiment of a simpler solution according to the present invention requiring far less memory is illustrated. An input data signal **30** is input with an address value signal **32** providing correction data for each pixel in the display **24**. The input signal may be analog or digital, although a digital signal is preferred. If a conversion of the input signal to a linear space is desired to improve accuracy of a correction, it may be performed through a look-up table **28** to form a linear input data signal **40**. This conversion may be a common conversion that is applied to all input signals, and may be based upon a series of measured brightness values and a priori knowledge of the display response to input signals.

The address value **32** (representing the location of a light emitting element in the display **24**) is applied to a look-up table **26** having a single entry for each light emitting element location. Preferably, a single, multi-bit integrated circuit memory is employed to reduce size and to minimize cost. Because storage is limited due to cost and size restrictions, the multi-bit storage is divided into first and second portions **26***a* and **26***b* and employed to store the two values associated with each light emitting element location: the offset **38** representing the maximum input signal value at which the light-emitting element will not emit more than a predefined minimum brightness, and the gain **36** representing the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal. The two values **36** and **38** may be stored with unequal precision; preferably the offset value **38** has fewer bits than the gain value **36**. The offset value **38** is applied to an adder **22** and the gain value **36** to a multiplier **20**. A multiply and an add operation are performed on the input data signal **30** or **40** to create a corrected data signal **34**. Since multiply and add operations **20** and **22** implement a linear transformation of the input signal, the order of operations **20**, **22** may be reversed without affecting the transformation result.

The corrected signal **34** is then applied to an EL display **24** to drive the EL display with improved uniformity. Note that the common linear space conversion **28**, while providing an input signal conversion to linear space, will not correct pixel uniformity. Hence, an individual linear transformation **20**, **22** for each pixel is still required. The corrected data signal **34** may be converted to an analog signal, if desired. A further transformation of the corrected signal to a display space may be provided to optimize the response of the display (not shown). Hence, according to the present invention a linear conversion of the signal space followed by a linear transformation to correct the signal output provides an improved correction method employing less memory and providing improved accuracy over prior art methods employing look-up tables alone or in combination with linear interpolations between selected values stored in look-up tables.

In an alternative embodiment, the maximum input signal value at which the light-emitting element will not emit more than a predefined minimum brightness is stored as a difference from a mean value and/or the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal is stored as a difference from a mean value. This may reduce the storage requirements of the correction values. The mean values may be stored in a controller, at another location in the memory, or in a driver circuit. In yet another embodiment, an indicator bit may be employed with the correction signals for each pixel to indicate when a cor-

rection is out of range. Out-of-range pixel corrections may be stored elsewhere in the memory, controller, or driving circuit.

In one embodiment, the memory for the look-up table **28** is packaged with an associated display device, to enable efficient packaging, shipment, and interconnection. Such a package can include a memory affixed to the display or to a connector fastened to the display and possibly sharing some of the connections of the connector.

According to a further embodiment of the present invention, the EL display **24** may be a color display with color pixels comprising, for example, red, green, and blue subpixels. For such a color display, a set of offset and gain values may be calculated for each sub-pixel, stored in a memory, and employed to correct an input signal, as described above. In order to minimize cost and size, a single integrated circuit memory having 32 bits (four bytes) of storage at each address location may be employed to provide 32 bits of correction information for each pixel. This storage may be divided in a variety of ways between the offset and gain values for each sub-pixel. For example, four bits may be employed for storing each of the red and blue offset values, six bits may be employed for storing each of the red and blue gain values, five bits may be employed for storing the green offset value and 7 bits for the green gain value. Since the human eye is most sensitive to green, additional information may be provided for the green channel. Alternatively, ten bits (four for offset and six for gain) may be provided for every color channel and the remaining two bits employed for other information. In a four-color pixel system (e.g. red, green, blue, and white), eight bits may be employed for each sub-pixel, for example with three bits of offset information and five bits of gain information. Alternatively, a larger memory having eight bits for each offset and gain value (6 bytes per pixel location) may be employed. In comparison with the prior art, this embodiment of the present invention may employ a lookup table of only 60,000 bytes for a 100-by-100-element display. A variety of memories having different numbers of bits per memory address are available commercially. In particular, memories with 8 bits or 32 bits per address location are known. In a further embodiment of the present invention, the corrections for each light-emitting element of a color in a color display may be adjusted to control the white point of the display.

Referring to FIG. **8**, a prior-art EL light-emitting element includes a substrate **210** on which is formed a first electrode **220**, a light-emitting layer **230**, and a second electrode **240**. Typically one of the two electrodes is transparent and the other electrode is reflective. The light-emitting layer **230** can include organic materials such as found in OLED devices or inorganic materials in a polycrystalline semiconductor matrix, for example quantum dots. (Explicitly referenced below). In a typical flat-panel display, and in particular for EL displays, thin-film transistors are used to drive the pixels. The thin-film transistors often have variable performance, for example, the voltage at which they turn on may vary from transistor to transistor. Hence, the uniformity of the pixels in the display will be compromised and a variety of different control signals needed to turn all of the pixels on at a common brightness. Moreover, the manufacturing process for the pixel elements may cause one pixel to have a different efficiency from another. Hence, the response to increasing signal values will not result in a comparable increase in pixel brightness for all pixels and the display will not be uniform. In particular, EL devices are subject to manufacturing variability depending on the process for materials deposition. In the case of OLED and hybrid organic-inorganic LEDs organic material vaporization non-uniformities lead to within-device variability. Other deposition methods including coating and inkjet printing can be used in manufacturing polymeric-LEDs (PLED) or EL devices containing colloidally formed quantum dots; these methods also have materials laydown variability associated with them. These types of variability can affect the efficiency of pixels in the display.

Referring to FIG. **4***a*, the light emitted in response to a variety of signal values for three pixels is illustrated. The first pixel begins emitting light at a first signal value and responds to an increasing signal value at a first rate as illustrated in the first signal value to light output curve **50**. Similarly, the second pixel begins emitting light at a second, different signal value and responds to an increasing signal value at a different rate as illustrated in the second signal value to light output curve **52**. Likewise, the third pixel begins emitting light at a third, different signal value and responds to an increasing signal value at a different rate as illustrated in the second signal value to light output curve **54**. As illustrated here, the value at which each of the three pixels begin emitting light is different, as is the rate at which their light output increases in response to increasing signal values.

According to the present invention, the brightness of the light-emitting elements is measured at two or more different data input signal values. Referring to FIG. **4***b*, the dots represent two light-output measurements **56** and **58** at two different data-input signal values. Referring to FIG. **4***c*, more than two measurements may be taken at more than two data input signal values and the results averaged to form a more accurate estimate of performance. In accordance with the invention, however, measurements need not be made for every possible input signal value.

According to an alternative embodiment of the present invention, the correction of the input data signal may be enhanced by first converting the input signal to a linear space in which the light output is linearly related to an increase in data input signal value, if it is not already in such a space. This conversion may be common to all light emitting elements, common to all light emitting elements of a common color, or individualized for each light-emitting element. Such conversions may be complex, since the relationship between signal value and brightness may be likewise complex, especially for a defective light-emitting element. Referring to FIG. **4***c*, e.g., rather than averaging the values to form a poor linear approximation of the performance of the light emitters, the three values can be fit to an equation that is then used to create a conversion to linearize the relationship between signal value and light output. The conversion can be done either with a computing circuit or a lookup table. The curve may not be monotonic and may have a complex shape, since the light emitter itself may be dysfunctional. Hence, a conversion of the input signal may be necessary to enable good results. The measurements shown in FIG. **4***c* according to this alternative embodiment may be the average output from all light emitting elements, the average output from all light-emitting elements of a common color, or the light output from each light-emitting element. Referring to FIG. **6**, this conversion may be accomplished by first measuring **90** the brightness of the light-emitting elements at three or more input signal values; fitting **92** an equation to match the measured brightness values; selecting **94** a desired maximum brightness level at a desired input signal value; and creating **96** an input signal conversion employing the equation and the desired maximum brightness level at a desired input signal value to convert the input signal to a converted input signal having a linear relationship between input signal value and brightness and a maximum brightness level at the desired input signal value to provide a converted **98** input signal.

If the EL display is a color display comprising light-emitting elements of multiple colors, separate conversions may be made for input signals for each color of light-emitting element thereby enabling independent corrections for each of the color planes in the EL display.

It is generally desirable to drive a display employing a range of input signal values from a minimum brightness to a maximum brightness for an application. For example, in a digital camera display, a brightness range from 0 cd/m^2 to 200 cd/m^2 may be desired. It is also desirable to provide a smooth gray scale between the minimum and maximum brightness values. This may be achieved by mapping the input signal from its minimum value (typically zero) to its maximum value (typically 255 for an 8-bit system). Hence, the predefined minimum brightness will preferably be defined to be zero cd/m^2. The desired input signal corresponding to the minimum brightness is likewise preferably zero. However, because of non-uniformities in output, a light emitting element may emit no light for input signal values greater than zero, hence to provide a smooth gray scale between the minimum and maximum brightness values, the maximum input signal value at which the light-emitting element will not emit any light must be estimated and mapped to the minimum input signal value desired (typically zero).

Once the input signal values are converted into a linear space, the offset and gain values can be employed to cause each pixel in a display to output the same amount of light by correcting the signal used to drive the display to provide a known output. For example, if it is desired to uniformly emit light over a range of brightnesses from 0 cd/m^2 to 200 cd/m^2 employing a signal from 0 to 255 (8 bits), and a pixel has an offset of 10 and a gain of 0.7 cd/bit, the signal must be multiplied by 1.12 and offset by 10 to provide the desired output. Of course, a limited number of bits in the offset and gain values and the circuitry will limit the precision and accuracy of the result. Generally, the more bits available, the more accurate will be the result.

In the case of using only two brightness measurements, the gain value may be simply estimated by finding the slope of the line formed by the two brightness measurements. The offset value may be estimated by finding the input signal value at which the brightness equals zero (i.e., where the line crosses the input signal value axis). It is preferred to make the measurements of brightness at well-separated data input signal values. Since any measurement has an inherent error, the estimation of the gain and offset values may be more accurate if the values are not close together. Referring to FIG. **4***e* in comparison to FIG. **4***d*, the dot represents the range of error possible. As can be seen by the variety of lines drawn through the dots where they are close together, a wider variety of offset and gain values may be obtained and reduced accuracy may result. Multiple measurements may be made to improve accuracy (as shown in FIG. **4***c*) by providing more data points to fit a line. A variety of algorithms for fitting data may be employed as known in the numerical analysis art.

Widely separated brightness measurements may be taken in an automated fashion by employing a measurement device for measuring the brightness of the EL device in response to the multi-valued input signal and including the steps of selecting the two or more different input signal values by driving at least one light-emitting element at a first input signal value and then increasing or decreasing the input signal value until the measured brightness reaches a maximum or minimum measured value, and employing the input signal value corresponding to the maximum or minimum measured value as the larger or smaller of the two-or-more different input signal values.

To determine widely separated brightness values, a process such as that shown in FIG. **7** may be employed to find suitable input signal values. Referring to FIG. **7**, a maximum brightness value may be obtained by first selecting **100** an arbitrary input signal value. The light output A corresponding to the arbitrary input signal is then measured **102**. The input signal value is then incremented **104** and the light output B corresponding to the incremented input signal measured **106**. A and B are compared **108**, and if equal either the output device has reached its maximum or the measurement device is saturated. In this case, the input signal value is decremented **110** and the light output B measured **112** and compared with A again **114**. If the values of A and B are still equal, the system is still saturated and the process continues until a difference is found. When the measured light output changes **116**, the input signal value corresponding to the previous measurement of B represents the minimum input signal value that will generate the maximum light output. If, in the initial comparison **108** of the values of A and B, the values are different, the maximum brightness is not necessarily reached and the value of A is set equal **120** to B, the input signal value is incremented **122** again, the output measured **124** and assigned to B, and the values of A and B are compared again. If the values are the same **116**, the input signal value corresponding to A represents the minimum input signal value that will generate the maximum light output and the process is complete **118**. If the values are not the same, the value of A is set equal **120** to B again, and the process repeats. The process of finding a minimum brightness value is similar to the process illustrated in FIG. **7**, except that rather than incrementing, the input signal value is decremented, and vice versa. The processes may be employed for individual light emitting elements, or may be employed for all elements in a device together.

If the EL display is a color display comprising light-emitting elements of multiple colors the process described in FIG. **7** may be repeated for each of the colors and separate two-or-more different input signal values may be selected for each color of light-emitting element.

Applicants have determined through experimentation that, despite measures taken to reduce the noise in the light output measurements, it can be difficult to consistently and accurately measure the light output from each of the light-emitting elements. In this case, it is possible to perform a global correction representing the average offset and gain of the device by measuring the output of all, or at least more than one, of the light-emitting elements. This can be done by measuring the overall brightness and gain of the EL display at one or more input signal values and adjusting the correction based on the measured overall brightness and gain. The correction is preferably done after the individual light-emitting elements have been corrected and the measurement made with as many of the light-emitting elements illuminated as possible. After measuring the offset and gain of the device as a whole, a global correction can be incorporated into each of the individual corrections of the light-emitting elements.

The measurements may be made by employing an optical measurement device (for example a digital camera) for measuring the brightness of the EL device in response to the multi-valued input signal. Applicants have determined that noise in the measurements (in particular sampling errors) may be reduced by including one or more of the steps of measuring the brightness of one or more light-emitting elements of the EL device with the optical measurement device focused on the EL device, and measuring the brightness of one or more light-emitting elements of the EL device with the optical measurement device defocused on the EL device. The separate measurements may be separately analyzed and their

results combined to create a preferred global correction. Alternatively, the focused and defocused measurements may be combined before they are analyzed. If a digital camera is employed to make the measurements, the resulting images represent the output of the EL light-emitting elements. These images may be processed using digital image processing means known in the art, for example averaging pixel values, identifying regions-of-interest around pixels, and determining characteristics of the regions such as centroids.

Even when employing a linear conversion, the brightness of alight-emitting element may not always be perfectly linearly related to the input signal values supplied to the display. Although the driving circuits used in such displays provide a functional transform in the relationship between the input signal values and the associated light-emitting element brightness, the desired correction factors for a light-emitting element may vary in non-linear ways at different brightness levels. Experiments performed by applicant have taught this is especially true for non-uniform light-emitting elements that, by definition, do not behave as desired or expected. In that case, if a linearizing conversion is not readily available, or is too costly or inaccurate, offsets and gains corresponding to a plurality of linear line segments may be employed to more closely approximate the actual performance of the light-emitting element. Referring to FIG. **4***f*, e.g., two line segments **60** and **62** are formed from three data points. Each consecutive pair of points may be used to calculate a different gain and offset value. These gain and offset values may be stored in the memory as described above. However, since they are range dependent (the appropriate offset and gain values depend on the data signal value) at least a portion of the input data signal must also be applied to the memory, as shown with the dotted line **30***a* in FIG. **2**. Applicants have determined that, even in the worst cases, only a few different sets of correction values need be employed to provide adequate accuracy, hence only the most significant bits of a digital input data signal typically would need to be applied to the memory **26**. For example, four different correction values may be employed over an 8-bit range: a first gain and offset value for the signal values ranging from 0-63, a second gain and offset value for the signal values ranging from 64-127, a third gain and offset value for the signal values ranging from 128-191, and a fourth gain and offset value for the signal values ranging from 192-255. In this example, only the two most significant bits are applied to the memory **26** and an increase in memory size of a factor of four is required to store the additional information.

In an alternative embodiment of the present invention, a simplified correction mechanism may be employed to further reduce the complexity and size of the correction hardware. Applicant has determined that a large number of significant non-uniformity problems are associated with rows and columns of light-emitting elements. This is attributable to the manufacturing process. Therefore, it is possible to reduce the memory size by grouping pixels and using common correction factors for each group. For example, since pixel addressing schemes typically uses an x,y address, rather than supplying an individual correction factor for every light-emitting element, correction factors for rows or columns might be employed. If all of the pixels in one dimension (for example, a row) have common correction factors a single set of correction factors may be employed for the entire group (for example, a row). In the limit, a single set of values may be employed for all of the pixels in the display. In these situations, the address range is much smaller and the memory needed is correspondingly decreased.

Computing circuitry for integer multiplications and additions using fractions are readily accomplished using conventional digital circuitry known in the art. Likewise analog solutions, for example employing operational amplifiers, are known in the art. Algebraic computations for lines are well known and employ, for example, equations of the form $y=mx+b$, where m represents the slope of the equation and the gain in the system and $-b/m$ the offset. The conversion may be accomplished by multiplying the input signal value by the reciprocal of the slope (1/m) and adding the offset ($-b/m$).

For example, referring to FIG. **5**, a light-emitting element may output 4 cd/m^2 when driven at a signal value of 6 and may output 16 cd/m^2 when driven with a signal value of 12. In this example, the performance of the light-emitting element in a linear space may be characterized as $L=2*V-8$, $L,V>=0$, where L is the light output in cd/m^2 and V is the value of the driving signal. The performance is illustrated with line segment **70** in FIG. **5**. The gain is then 2 and the offset is 4. If the desired output is as shown with line segment **72** in FIG. **5**, then the correction circuitry converts the actual output (**70**) to the desired output (**72**). That is, the desired output function (**72**) must be mapped onto the actual output function (**70**). As noted above, this conversion is accomplished by multiplying the input signal value by the reciprocal of the slope (in this example 0.5) and adding the offset (in this example 4) to determine a corrected signal value that will create the desired output, that is: corrected signal value=(input signal value)/gain+offset (in this example corrected signal value=(input signal value)/2+4).

Other functions can be mapped similarly. If the offset value is negative (that is the output of a light-emitting element cannot be turned off), an offset of zero may be employed for the defective light-emitting element. Alternatively, it may be desirable to map all light-emitting elements to match the performance of the defective light-emitting elements. The multiplication value may be either greater or less than one. If a multi-segment correction is employed (as illustrated in FIG. **4***f*), the gain and offset for each segment should be calculated and employed for input signals in the range corresponding to the segment.

Means to measure the brightness of each light-emitting element in a display are known and described, for example, in the references provided above. In a particular embodiment, systems and methods as described in copending, commonly assigned U.S. Ser. No. 10/858,260, filed Jun. 1, 2004, may be employed, the disclosure of which is incorporated by reference herein.

In typical applications, displays are sorted after manufacture, into groups that may be applied to different purposes. Some applications require displays having no, or only a few, faulty light-emitting elements. Others can tolerate variability but only within a range, while others may have different lifetime requirements. The present invention provides a means to customize the performance of an EL display to the application for which it is intended. It is well known that EL devices rely upon the current passing through them to produce light. In the case of OLED, PLED and hybrid organic-inorganic displays, as the current passes through the materials, the materials age and become less efficient. By applying a correction factor to a light-emitting element to increase its brightness, a greater current is passed through the light-emitting element, thereby reducing the lifetime of the light-emitting element while improving the uniformity.

The correction factors applied to an EL device may be related to the expected lifetime of the materials and the lifetime requirements of the application for which the display is intended. The maximum combined correction factor may be set, e.g., so as to not exceed the ratio of the expected lifetime of the display materials to the expected lifetime of the display

in the intended application. For example, if a display has an expected lifetime of 10 years at a desired brightness level, and an application of that display has a requirement of 5 years, the maximum combined correction factor for that display may be set so as not to exceed two, if the current-to-lifetime relationship is linear. If the relationship is not linear, a transformation to relate the lifetime and current density may be employed. These relationships can be obtained empirically. Hence, the combined correction factor for a display may be limited by application. Alternatively, one can view this relationship as a way to improve the yields in a manufacturing process by enabling uniformity correction in a display application (up to a limit) so that displays that might have been discarded, may now be used. Moreover, EL devices having more-efficient light-emitting elements may have a reduced power requirement thereby enabling applications with more stringent power requirements.

The display requirements may be further employed to improve manufacturing yields by correcting the uniformity of specific light-emitting elements or only partially correcting the uniformity of the light-emitting elements. Some applications can tolerate a number of non-uniform light-emitting elements. These light-emitting elements may be chosen to be more or less noticeable to a user depending on the application and may remain uncorrected, or only partially corrected, thereby allowing the maximum combined correction factor to remain under the limit described above. For example, if a certain number of bad light-emitting elements were acceptable, the remainder may be corrected as described in the present invention and the display made acceptable. In a less extreme case, bad light-emitting elements may be partially corrected so as to meet the lifetime requirement of the display application and partially correcting the uniformity of the display. Hence, the correction factors may be chosen to exclude light-emitting elements, or only partially correct light-emitting elements, that fall outside of a correctable range. This range, as observed above, may be application dependent.

There are a variety of ways in which light-emitting elements may be excluded from correction. For example, a minimum or maximum threshold may be provided outside of which no light-emitting elements are to be corrected. The threshold may be set by comparing the expected lifetime of the materials and the application requirements.

In a preferred embodiment, the present invention is employed in a flat-panel OLED device composed of small molecule or polymeric OLEDs as disclosed in but not limited to U.S. Pat. No. 4,769,292, issued Sep. 6, 1988 to Tang et al., and U.S. Pat. No. 5,061,569, issued Oct. 29, 1991 to VanSlyke et al. In another preferred embodiment, the present invention is employed in a flat-panel inorganic LED device containing quantum dots as disclosed in, but not limited to U.S. Patent Application Publication No, 2007/0057263 entitled "Quantum dot light emitting layer" and pending U.S. application Ser. No. 11/683,479, by Kahen, which are both hereby incorporated by reference in their entirety. Many combinations and variations of organic, inorganic and hybrid light-emitting displays can be used to fabricate such a device, including both active- and passive-matrix LED displays having either a top- or bottom-emitter architecture.

The invention has been described in detail with particular reference to certain preferred embodiments thereof, but it will be understood that variations and modifications can be effected within the spirit and scope of the invention.

PARTS LIST

8 Provide display step
10 measure brightness step
11 convert signal step
12 estimate parameters step
14 convert signal step
16 correct signal step
18 output corrected signal step
20 multiplier
22 adder
24 display
26 memory
26*a* first portion of memory
26*b* second portion of memory
28 conversion lookup table
30 data input signal
30*a* portion of data input signal
32 address signal
34 corrected data input signal
36 gain correction signal
38 offset correction signal
40 converted data signal
50 first signal value to light output curve
52 second signal value to light output curve
54 third signal value to light output curve
56 first measurement value
57 third measurement value
58 second measurement value
60 first line segment
62 second line segment
70 actual signal response
72 desired signal response
80 lookup table
90 measure luminance step
92 fit equation step
94 select output values step
96 create conversion step
98 convert signal step
100 select initial value step
102 measure light step
104 increment value step
106 measure light step
108 compare measurements step
110 decrement value step
112 measure light step
114 compare measurements step
116 determine maximum step
118 task complete step
120 assign measurement value step
122 increment value step
124 measure light step
126 compare measurements step
210 substrate
220 electrode
230 EL light-emitting layer
240 electrode

The invention claimed is:

1. A method for the correction of average brightness or brightness uniformity variations in electroluminescent (EL) displays, comprising:

a) providing an EL display having one or more light-emitting elements responsive to a multi-valued input signal for causing the light-emitting elements to emit light at a plurality of brightness levels;

b) measuring the brightness of each light-emitting element at two or more, but fewer than all possible, different input signal values;

c) employing the measured brightness values to estimate a maximum input signal value at which the light-emitting element will not emit more than a predefined minimum

brightness and the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal; and

d) using the estimated maximum input signal value at which the light-emitting element will not emit light more than the predefined minimum brightness and the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal to modify the input signal to a corrected input signal to correct the light output of the light-emitting elements.

2. The method of claim **1**, wherein the EL display provided contains light-emitting quantum dots.

3. The method of claim **1**, wherein the modification of the input signal to a corrected input signal comprises a linear transformation.

4. The method of claim **1**, wherein the EL display has more than one light-emitting element and the corrected input signal improves the brightness uniformity of the EL display.

5. The method of claim **1**, wherein the EL display is a color display comprising light-emitting elements of multiple colors.

6. The method of claim **5**, wherein the white point of the display is adjusted by adjusting the input signal modifications for each light-emitting element to modify the average brightness of the display for each color of light.

7. The method of claim **1**, wherein the input signal modifications for each light-emitting element are adjusted to modify the average brightness of the display.

8. The method of claim **1**, wherein maximum input signal values at which the light-emitting elements will not emit light above the predefined minimum brightness and rates at which the brightness of the light-emitting elements increase above the predefined minimum brightness in response to increases in the value of the input signal that have been estimated based on the brightness values of light-emitting elements measured at only two different input signal values are employed to modify the input signal to a corrected input signal for the entire range of the multi-valued input signal to correct the light output of the light-emitting elements.

9. The method of claim **1**, wherein the brightness of each light-emitting element is measured at more than two different input signal values and the measurements are combined to estimate the maximum input signal value at which the light-emitting element does not emit light above the predefined minimum brightness and the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal.

10. The method of claim **1**, wherein the brightness of each light-emitting element is measured at more than two different input signal values and each consecutive pair of measurements are combined to estimate the maximum input signal value at which the light-emitting element does not emit light above a predefined minimum brightness and the rate at which the brightness of the light-emitting element increases above a predefined minimum brightness in response to increases in the value of the input signal for each pair, and the estimated values are applied for modification of input signals in each measurement range.

11. The method of claim **1**, wherein the estimated maximum input signal value at which the light-emitting element will not emit light above a predefined minimum brightness and the rate at which the brightness of the light-emitting element increases above a predefined minimum brightness in response to increases in the value of the input signal for each light-emitting element are stored as correction values within a lookup table.

12. The method of claim **11**, wherein the correction values for each light-emitting element are stored together at single address locations of the lookup table.

13. The method of claim **1** wherein the maximum input signal value at which the light-emitting element will not emit more than a predefined minimum brightness is stored with a first number of bits and the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal is stored at a second number of bits, and wherein the first and second number of bits are different.

14. The method of claim **1** wherein the maximum input signal value at which the light-emitting element will not emit more than a predefined minimum brightness is stored as a difference from a mean value and/or the rate at which the brightness of the light-emitting element increases above the predefined minimum brightness in response to increases in the value of the input signal is stored as a difference from a mean value.

15. The method of claim **1**, further comprising a conversion to convert the measurements and/or input signals into a linear space before the estimations and/or modifications are performed.

16. The method of claim **1**, further comprising the steps of calculating the conversion by:

a) measuring the brightness of the light-emitting elements at three or more input signal values;

b) fitting an equation to match the measured brightness values;

c) selecting a desired maximum brightness level at a desired input signal value; and

d) creating an input signal conversion employing the equation and the desired maximum brightness level at a desired input signal value to convert the input signal to a converted input signal having a linear relationship between input signal value and brightness and a maximum brightness level at the desired input signal value.

17. The method of claim **16**, wherein the brightness values measured for calculating the conversion are average brightness values of the light emitting elements.

18. The method of claim **15**, wherein the EL display is a color display comprising light-emitting elements of multiple colors and separate common conversions are made for input signals for each color of light-emitting element.

19. The method of claim **1**, further comprising selecting the two or more different input signal values by driving at least one light emitting element at a first input signal value and then increasing or decreasing the input signal value until the measured brightness reaches a maximum or minimum measured value, and employing the input signal value corresponding to the maximum or minimum measured value as the larger or smaller of the two-or-more different input signal values.

20. The method of claim **19**, wherein the EL display is a color display comprising light-emitting elements of multiple colors and independently selecting two-or-more different input signal values for each color of light-emitting element.

* * * * *

专利名称(译)	用于显示器中的均匀性和亮度校正的方法和设备		
公开(公告)号	US8013814	公开(公告)日	2011-09-06
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[标]申请(专利权)人(译)	库克群岛RONALD小号 FORD JAMES ^ h		
申请(专利权)人(译)	库克群岛RONALD小号 FORD JAMES ^ h		
当前申请(专利权)人(译)	全球OLED科技有限责任公司		
[标]发明人	COK RONALD S FORD JAMES H		
发明人	COK, RONALD S. FORD, JAMES H.		
IPC分类号	G09G3/30 G09G3/32 G09G5/00 G06F3/038		
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其他公开文献	US20070296653A1		
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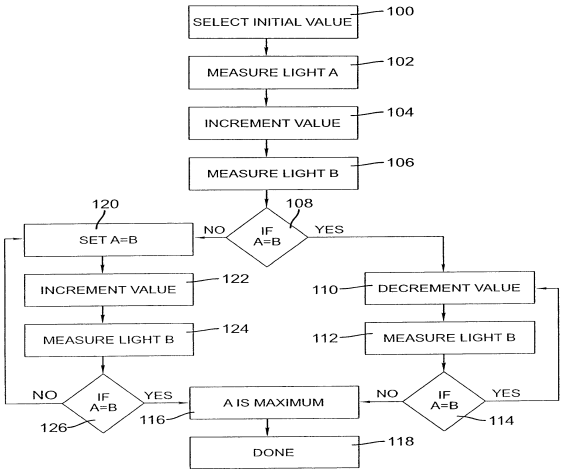
摘要(译)

一种校正电致发光（EL）显示器中的平均亮度或亮度均匀性变化的方法，包括：a）提供EL显示器，该EL显示器具有响应于多值输入信号的一个或多个发光元件，用于使发光元件以多个亮度级发光; b）以两个或更多但不是所有可能的不同输入信号值测量每个发光元件的亮度; c）使用测量的亮度值来估计发光元件不会发射超过预定的最小亮度的最大输入信号值以及发光元件的亮度增加到高于预定的最小亮度的速率。响应输入信号值的增加; d）使用估计的最大输入信号值，在该最大输入信号值处发光元件将不发光超过预定的最小亮度，并且发光元件的亮度响应于增加而增加到高于预定的最小亮度的速率在输入信号的值中，将输入信号修改为校正后的输入信号，以校正发光元件的光输出。